## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10584334	SHIN ET AL.
Examiner	Art Unit
IIIIIO DEDEZ	0047

SEARCHED			
Class	Subclass	Date	Examiner
455	423, 37.11	5/7/2010	JP

SEARCH NOTES		
Search Notes	Date	Examiner
East (text search)	5/7/2010	JP
Inventor's search	5/7/2010	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/J. P./ Examiner.Art Unit 2617	

U.S. Patent and Trademark Office Part of Paper No.: 20100505